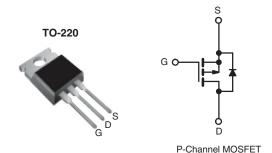


COMPLIANT



Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 100			
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = - 10 V	1.2		
Q _g (Max.) (nC)	8.7			
Q _{gs} (nC)	2.2			
Q _{gd} (nC)	4.1			
Configuration	Single			



FEATURES

- · Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- P-Channel
- 175 °C Operating Temperature
- · Fast Switching
- · Ease of Paralleling
- · Simple Drive Requirements
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION		
Package	TO-220	
Lond (Dh.) from	IRF9510PbF	
Lead (Pb)-free	SiHF9510-E3	
SnPb	IRF9510	
SHED	SiHF9510	

ABSOLUTE MAXIMUM RATINGS T _C = 25 °C, unless otherwise noted						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 100	V	
Gate-Source Voltage			V_{GS}	± 20	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	
Continuous Drain Current	V _{GS} at - 10 V	T _C = 25 °C	I _D	- 4.0		
	V _{GS} at - 10 V	T _C = 100 °C		- 2.8	Α	
Pulsed Drain Current ^a			I _{DM}	- 16		
Linear Derating Factor				0.29	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	200	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 4.0	Α	
Repetitive Avalanche Energy ^a			E _{AR}	4.3	mJ	
Maximum Power Dissipation	T _C = 25 °C		P_{D}	43	W	
Peak Diode Recovery dV/dtc			dV/dt	- 5.5	V/ns	
Operating Junction and Storage Temperature Range			T_J,T_stg	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	7	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 18 mH, R_G = 25 Ω , I_{AS} = 4.0 A (see fig. 12).
- c. $I_{SD} \le$ 4.0 A, dI/dt \le 75 A/µs, $V_{DD} \le V_{DS},\, T_J \le$ 175 °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRF9510, SiHF9510

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	62		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.5		

SPECIFICATIONS $T_J = 25 ^{\circ}C$, U	unless otherv	vise noted					
PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V_{DS}	$V_{GS} = 0$	V _{GS} = 0 V, I _D = - 250 μA		-	-	٧
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I _D = - 1 mA	-	- 0.091	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V$	' _{GS} , I _D = - 250 μA	- 2.0	-	- 4.0	٧
Gate-Source Leakage	I _{GSS}	V	_{GS} = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = - 100 V, V _{GS} = 0 V		-	- 100	μΑ
Drain-Source On-State Resistance	R _{DS(on)}		$V_{GS} = 0 \text{ V}, T_J = 150 \text{ °C}$ $I_D = -2.4 \text{ Ab}$	-	-	- 500 1.2	Ω
Forward Transconductance	9fs		50 V, I _D = - 2.4 A ^b	1.0	_	-	S
Dynamic	915	105 -	20 1, 10 - 2.171	1.0			
Input Capacitance	C _{iss}			_	200	_	
Output Capacitance	C _{oss}		$V_{GS} = 0 \text{ V},$ $V_{DS} = -25 \text{ V},$		94	_	pF
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	18	_	PΓ
Total Gate Charge	Q _q		I _D = -4.0 A, V _{DS} = -80 V, see fig. 6 and 13 ^b	_	-	8.7	nC
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		_	_	2.2	
Gate-Drain Charge	Q _{gd}	1 1 1 1 1		_	-	4.1	
Turn-On Delay Time	t _{d(on)}			-	10	-	
Rise Time	t _r	V ₂₂	V _{DD} = - 50 V, I _D = - 4.0 A,		27	_	ns
Turn-Off Delay Time	t _{d(off)}	$R_{\rm G} = 24 \ \Omega, \ R_{\rm D} = 11 \ \Omega, \ {\rm see \ fig. \ } 10^{\rm b}$		-	15	-	
Fall Time	t _f			_	17	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s	L			1		
Continuous Source-Drain Diode Current	Is	MOSFET symb	MOSFET symbol		-	- 4.0	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 16	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = - 4.0 A, V _{GS} = 0 V ^b		-	-	- 5.5	V
Body Diode Reverse Recovery Time	t _{rr}	$T_{J} = 25 \text{ °C}, I_{F} = -4.0 \text{ A, dl/dt} = 100 \text{ A/}\mu\text{s}^{b}$		-	82	160	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	0.15	0.30	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

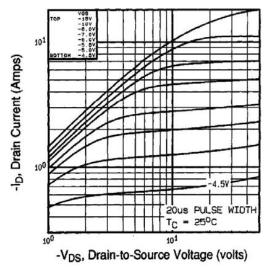


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

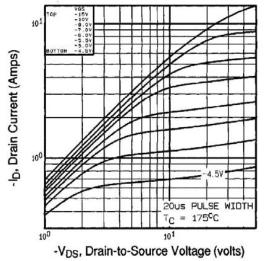


Fig. 2 - Typical Output Characteristics, T_C = 175 $^{\circ}C$

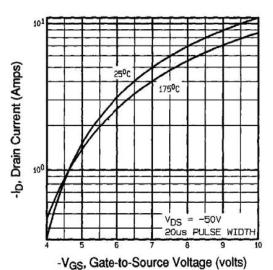


Fig. 3 - Typical Transfer Characteristics

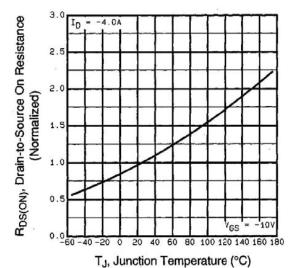
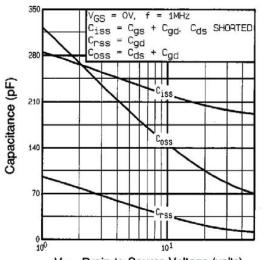


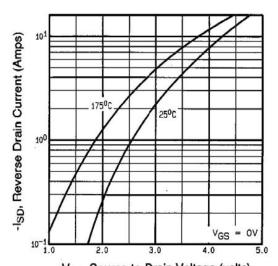
Fig. 4 - Normalized On-Resistance vs. Temperature

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-V_{DS}, Drain-to-Source Voltage (volts)
Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage



-V_{SD}, Source-to-Drain Voltage (volts)
Fig. 7 - Typical Source-Drain Diode Forward Voltage

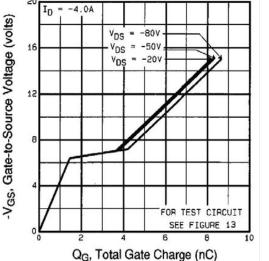


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

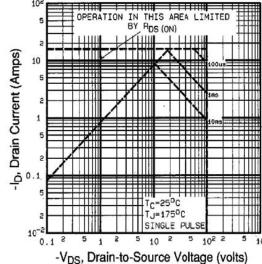


Fig. 8 - Maximum Safe Operating Area





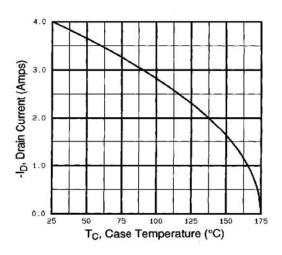


Fig. 9 - Maximum Drain Current vs. Case Temperature

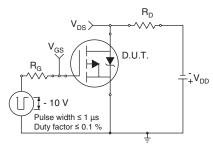


Fig. 10a - Switching Time Test Circuit

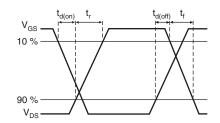
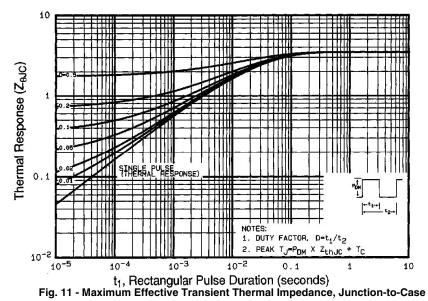


Fig. 10b - Switching Time Waveforms



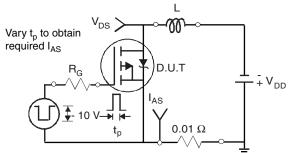


Fig. 12a - Unclamped Inductive Test Circuit

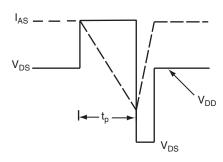


Fig. 12b - Unclamped Inductive Waveforms

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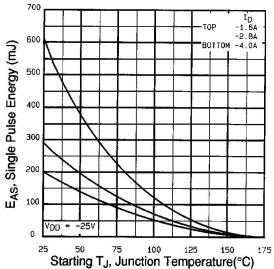


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

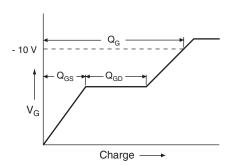


Fig. 13a - Basic Gate Charge Waveform

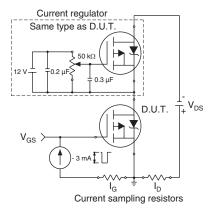
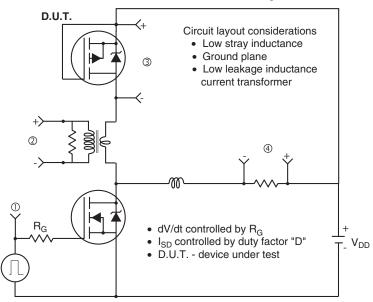


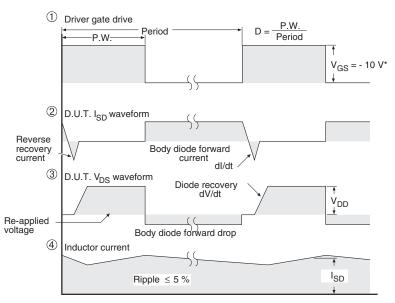
Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



• Compliment N-Channel of D.U.T. for driver



* V_{GS} = - 5 V for logic level and - 3 V drive devices

Fig. 14 - For P-Channel

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